Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10632499	OLSCHEWSKI, FRANK
Examiner	Art Unit
Dennis Rosario	2624

SEARCHED						
Class	Subclass	Date	Examiner			
382	103	3/6/08	DR			
348	169	3/6/08	DR			
382	103 updated	9/2/08	DR			
		3/24/09	DR			
345	181	3/24/09	DR			
348	169-172, 208.14	3/24/09	DR			
359	383	3/24/09	DR			
396	51	3/24/09	DR			

SEARCH NOTES				
Search Notes	Date	Examiner		
East, all dB	3/6/08	DR		
ACM-+microscope +trajectory +vector-	3/6/08	DR		
IEEE- ((((microscope) <in>metadata)<and>((track*)<in>metadata))<and>((vector) <in>metadata))-</in></and></in></and></in>	3/6/08	DR		
East, all db, updated	9/2/08	DR		
IEEE-((trajector* <near 5=""> pixel)<in>metadata)-</in></near>	9/2/08	DR		
East, all db	3/24/09	DR		
Google Scholar-trajectory pixel vector field-	3/24/09	DR		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examine		

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